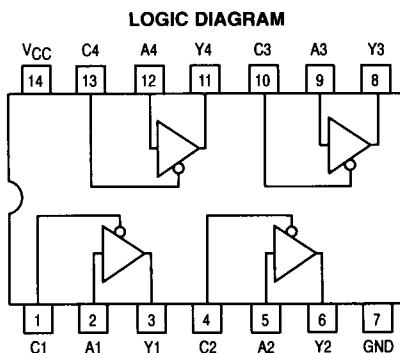




**MOTOROLA**

## Quad 3-State Buffer Low Enable

ELECTRICALLY TESTED PER:  
MPG54F125

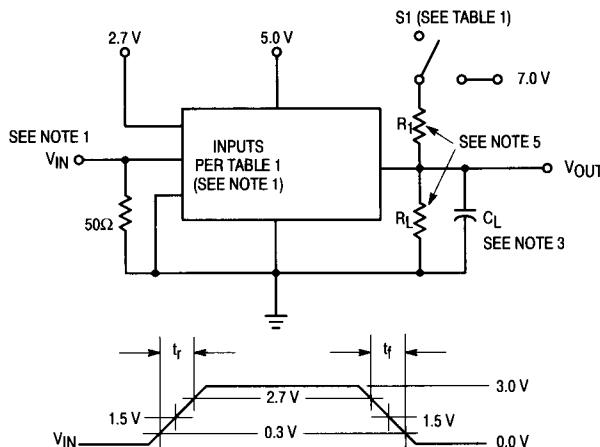


Positive Logic:

Y = A

Output is off (disabled) when C is high.

### AC TEST CIRCUIT



REFERENCE NOTES ON PAGE 4-39

**Military 54F125**



### AVAILABLE AS:

- 1) JAN: N/A
- 2) SMD: N/A
- 3) 883: 54F125/BXAJC

X = CASE OUTLINE AS FOLLOWS:  
PACKAGE: CERDIP; C  
CERFLAT: D  
LCC: 2

THE LETTER "M" APPEARS  
BEFORE THE / ON LCC.

### PIN ASSIGNMENTS

FUNCT.	DIL 632-08	FLATS 717-04	LCC 756A-02	BURN-IN (COND. A)
C1	1	1	2	GND
A1	2	2	3	V <sub>CC</sub>
Y1	3	3	4	OPEN
C2	4	4	6	GND
A2	5	5	8	V <sub>CC</sub>
Y2	6	6	9	OPEN
GND	7	7	10	GND
Y3	8	8	12	OPEN
A3	9	9	13	V <sub>CC</sub>
C3	10	10	14	GND
Y4	11	11	16	OPEN
A4	12	12	18	V <sub>CC</sub>
C4	13	13	19	GND
V <sub>CC</sub>	14	14	20	V <sub>CC</sub>

BURN-IN CONDITIONS:  
V<sub>CC</sub> = 5.0 V MIN/6.0 V MAX

### FUNCTION TABLE

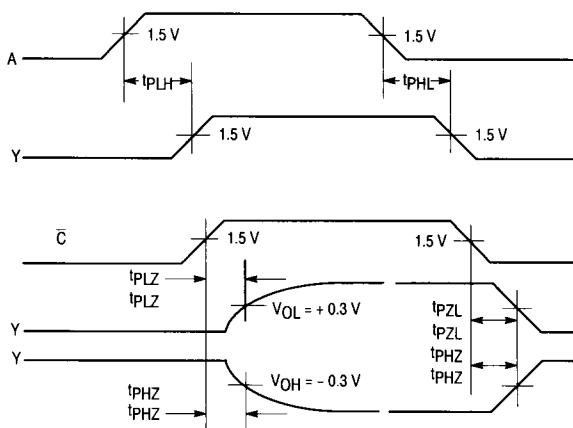
Inputs		Output
̄C	A	Y
L	L	L
L	H	H
H	X	(Z)

H = HIGH Voltage Level

L = LOW Voltage Level

X = Don't Care

## WAVEFORMS



## NOTES:

1. Input pulse generator has the following characteristics:  
PRR = 1.0 MHz,  $t_r = t_f \leq 2.5$  ns and  $Z_{OUT} \approx 50 \Omega$ .
2. Terminal conditions (pins not designated may be high  $\geq 2.0$  V, low  $\leq 0.8$  V, or open).
3.  $C_L = 50 \text{ pF} \pm 10\%$  including scope probe, wiring and stray capacitance, without package in test fixture.
4. Voltage measurements are to be made with respect to network ground terminal.
5.  $R_L = R_1 = 500 \Omega \pm 5.0\%$ .

Table 1

Test Type	S1
$t_{PLH}$	open
$t_{PHL}$	open
$t_{PHZ}$	open
$t_{PZH}$	open
$t_{PLZ}$	closed
$t_{PZL}$	closed

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
		+ 25°C		+ 125°C		- 55°C			
Static Parameters:	Subgroup 1		Subgroup 2		Subgroup 3				
	Min	Max	Min	Max	Min	Max			
$V_{OH}$	Logical "1" Output Voltage	2.4		2.4		2.4		V	$V_{CC} = 4.5 \text{ V}$ , $I_{OH} = -3.0 \text{ mA}$ , $V_{IN} = 2.0 \text{ V}$ , other input is $= 0.8 \text{ V}$ .
$V_{OL}$	Logical "0" Output Voltage		0.5		0.5		0.5	V	$V_{CC} = 4.5 \text{ V}$ , $I_{OL} = 48 \text{ mA}$ , $V_{IN} = 0.8 \text{ V}$ (both inputs).
$V_{IC}$	Input Clamping Voltage		-1.2					V	$V_{CC} = 4.5 \text{ V}$ , $I_{IN} = -18 \text{ mA}$ , other inputs are open.
$I_{IH}$	Logical "1" Input Current		20		20		20	$\mu\text{A}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IH} = 2.7 \text{ V}$ , $V_{IN} = \text{GND}$ , other inputs are open.
$I_{IHH}$	Logical "1" Input Current		100		100		100	$\mu\text{A}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IHH} = 7.0 \text{ V}$ , $V_{IN} = \text{GND}$ , other inputs are open.
$I_{IL}$	Logical "0" Input Current	0	-20	0	-20	0	-20	$\mu\text{A}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IL} = 0.5 \text{ V}$ , other inputs are open.
$I_{IIL}$	Logical "0" Input Current	0	-20	0	-20	0	-20	$\mu\text{A}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IIL} = 0.5 \text{ V}$ , other input = 0 V.
$I_{OS}$	Output Short Circuit Current	-100	-225	-100	-225	-100	-225	$\text{mA}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IN} = 4.5 \text{ V}$ , other input is GND, $V_{OUT} = \text{GND}$ .
$I_{IOZH}$	Output Off Current High		50		50		50	$\mu\text{A}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IN} = 2.0 \text{ V}$ , other input = 0 V, $V_{OUT} = 2.7 \text{ V}$ .
$I_{IOZL}$	Output Off Current Low		-50		-50		-50	$\mu\text{A}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IN} = 2.0 \text{ V}$ , other input = 4.5 V, $V_{OUT} = 0.5 \text{ V}$ .
$I_{CCH}$	Power Supply Current		24		24		24	$\text{mA}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IN} = 4.5 \text{ V}$ , other input = 0 V.
$I_{CCL}$	Power Supply Current		40		40		40	$\text{mA}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IN} = 0 \text{ V}$ (all inputs).
$I_{CCZ}$	Power Supply Current Off		35		35		35	$\text{mA}$	$V_{CC} = 5.5 \text{ V}$ , $V_{IN} = 4.5 \text{ V}$ , other inputs are open.
$V_{IH}$	Logical "1" Input Voltage	2.0		2.0		2.0		V	$V_{CC} = 4.5 \text{ V}$ .
$V_{IL}$	Logical "0" Input Voltage		0.8		0.8		0.8	V	$V_{CC} = 4.5 \text{ V}$ .

## 54F125

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)	
	Functional Tests	+ 25°C		+ 125°C		– 55°C			per Truth Table with $V_{CC} = 4.5$ V, <b>(Repeat at)</b> $V_{CC} = 5.5$ V, $V_{IL} = 0.5$ V, and $V_{IH} = 2.4$ V.	
		Subgroup 7		Subgroup 8A		Subgroup 8B				
Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)	
	Switching Parameters:	+ 25°C		+ 125°C		– 55°C				
		Subgroup 9		Subgroup 10		Subgroup 11				
		Min	Max	Min	Max	Min	Max			
t <sub>PHL</sub>	Propagation Delay /Data-Output Output High-Low	3.0	7.5	3.0	9.0	3.0	9.0	ns	$V_{CC} = 5.0$ V, $C_L = 50$ pF, $R_L = R_1 = 500$ Ω.	
t <sub>PLH</sub>	Propagation Delay /Data-Output Output Low-High	2.0	6.0	2.0	7.5	2.0	7.5	ns	$V_{CC} = 5.0$ V, $C_L = 50$ pF, $R_L = R_1 = 500$ Ω.	
t <sub>PLZ</sub>	Propagation Delay /Data-Output Output Low-High	1.5	5.5	1.5	7.0	1.5	7.0	ns	$V_{CC} = 5.0$ V, $C_L = 50$ pF, $R_L = R_1 = 500$ Ω.	
t <sub>PHZ</sub>	Propagation Delay /Data-Output Output High-Low	1.5	5.0	1.5	7.0	1.5	7.0	ns	$V_{CC} = 5.0$ V, $C_L = 50$ pF, $R_L = R_1 = 500$ Ω.	
t <sub>PZL</sub>	Propagation Delay /Data-Output Output Low-High	3.0	8.0	3.0	10	3.0	10	ns	$V_{CC} = 5.0$ V, $C_L = 50$ pF, $R_L = R_1 = 500$ Ω.	
t <sub>PZH</sub>	Propagation Delay /Data-Output Output High-Low	3.0	7.5	3.0	9.0	3.0	9.0	ns	$V_{CC} = 5.0$ V, $C_L = 50$ pF, $R_L = R_1 = 500$ Ω.	